

Search Notes

Application/Control No.

10/618,807

Examiner

M. Lee

Applicant(s)/Patent under
Reexamination

UEKI, KEIJIRO

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
348	643 -	3/13/2006	ML
	644		
	624		
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	708		
	713		
H04N	9/70		
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference search history printout		3/13/2006	ML

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/13/2006	ML